

**DESCRIPTION**

The AM04NN08M is available in SOP-8 Package.

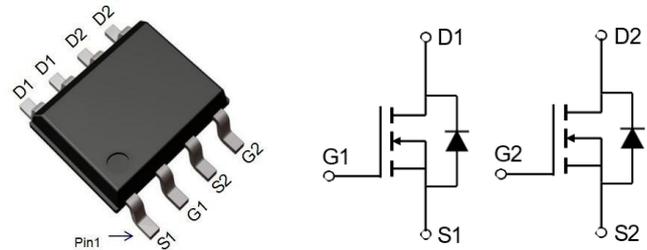
BVDSS	RDSON	ID
40V	13mΩ	8A

**FEATURES**

- 40V, 8A
- $R_{DS(ON)}$  Typ = 13mΩ @  $V_{GS} = 10V$
- Advanced Trench Technology
- Excellent  $R_{DS(ON)}$  and Low Gate Charge

**APPLICATION**

- Load Switch
- PWM Application
- Power Management

**PIN DESCRIPTION****ORDERING INFORMATION**

Package Type	Part Number	
SOP-8 SPQ: 4,000pcs/Reel	M8	AM04NN08MM8VR
Note	R: Tape & Reel V: Halogen free Package	
AiT provides all RoHS products		

Pin#	Symbol	Function
1,3,4	S	Source
2	G	Gate
5,6,7,8	D	Drain

**ABSOLUTE MAXIMUM RATINGS**

$T_J = 25^\circ\text{C}$  unless otherwise specified

$V_{DS}$ , Drain-to-Source Voltage	40V	
$V_{GS}$ , Gate-to-Source Voltage	±20V	
$I_D$ , Continuous Drain Current	$T_A = 25^\circ\text{C}$	8A
	$T_A = 100^\circ\text{C}$	4.8A
$I_{DM}$ , Pulsed Drain Current <sup>(1)</sup>	32A	
$E_{AS}$ , Single Pulse Avalanche Energy <sup>(2)</sup>	25mJ	
$P_D$ , Power Dissipation	$T_A = 25^\circ\text{C}$	1.9W
$R_{\theta JC}$ , Thermal Resistance, Junction to Case	65°C/W	
$T_J, T_{STG}$ , Junction & Storage Temperature Range	-55°C ~ +150°C	

Stresses above may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated in the Electrical Characteristics are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

(1) Repetitive rating, pulse width limited by junction temperature.

(2)  $E_{AS}$  condition: Starting  $T_J=25^\circ\text{C}$ ,  $V_{DD}=20V$ ,  $V_G=10V$ ,  $R_G=25\text{ohm}$ ,  $L=0.5\text{mH}$ ,  $I_{AS}=10A$

**ELECTRICAL CHARACTERISTICS**T<sub>J</sub>=25°C, unless otherwise noted.

Parameter	Symbol	Conditions	Min	Typ.	Max	Unit
<b>Off Characteristics</b>						
Drain-Source Breakdown Voltage	V <sub>(BV)DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	40	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 40V, V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V, V <sub>DS</sub> = 0V	-	-	±100	nA
<b>On Characteristics</b>						
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250μA	1	1.5	2	V
Static Drain Source ON-Resistance <sup>(3)</sup>	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =8A	-	13	16.9	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =6A		17	22.1	
<b>Dynamic Characteristics</b>						
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =20V, V <sub>GS</sub> =0V, f=1MHz	-	1000	-	pF
Output Capacitance	C <sub>oss</sub>		-	84	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	63	-	
Total Gate Charge	Q <sub>g</sub>	V <sub>GS</sub> =0 to 10V, V <sub>DS</sub> =20V, I <sub>D</sub> =5A	-	14	-	nC
Gate Source Charge	Q <sub>gs</sub>		-	4	-	
Gate-Drain("Miller") Charge	Q <sub>gd</sub>		-	4.5	-	
<b>Switching Characteristics</b>						
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>GS</sub> =10V, V <sub>DD</sub> =20V R <sub>GEN</sub> =3Ω, I <sub>D</sub> =5A	-	10	-	ns
Turn-On Rise Time	t <sub>r</sub>		-	12	-	
Turn-Off Delay Time	t <sub>d(off)</sub>		-	33	-	
Turn-Off Fall Time	t <sub>f</sub>		-	10	-	
<b>Drain-Source Diode Characteristics and Max Ratings</b>						
Maximum Continuous Drain to Source Diode Forward Current	I <sub>S</sub>	-	-	-	8	A
Maximum Pulsed Drain to Source Diode Forward Current	I <sub>SM</sub>	-	-	-	32	A
Drain to Source Diode Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =8A	-	-	1.2	V
Body Diode Reverse Recovery Time	T <sub>rr</sub>	I <sub>F</sub> =5A, di/dt =100A/us	-	19	-	nS
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>		-	11	-	nC

(3) R<sub>θJA</sub> is measured with the device mounted on a 1inch<sup>2</sup> pad of 2oz copper FR4 PCB



(4)Pulse Test: Pulse Width $\leq$ 300 $\mu$ s, Duty Cycle $\leq$ 0.5%.

## TEST CIRCUIT

Fig 1. Gate Charge Test Circuit & Waveform

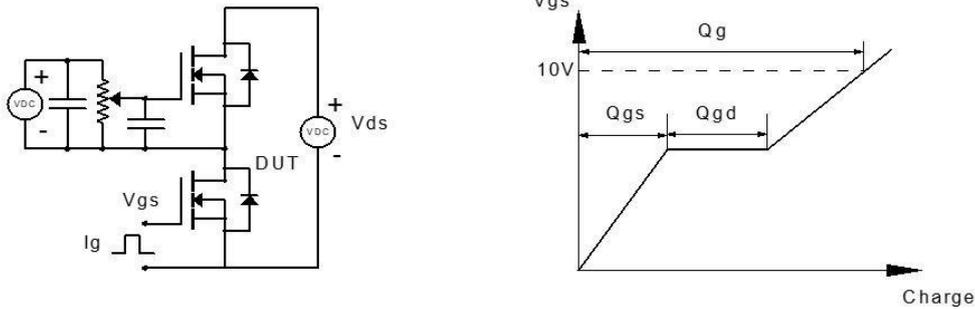


Fig 2. Resistive Switching Test Circuit & Waveform

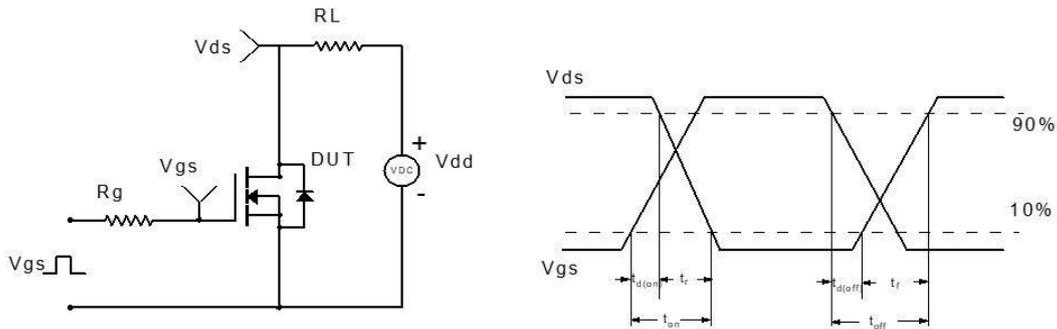


Fig 3. Unclamped Inductive Switching Test Circuit & Waveform

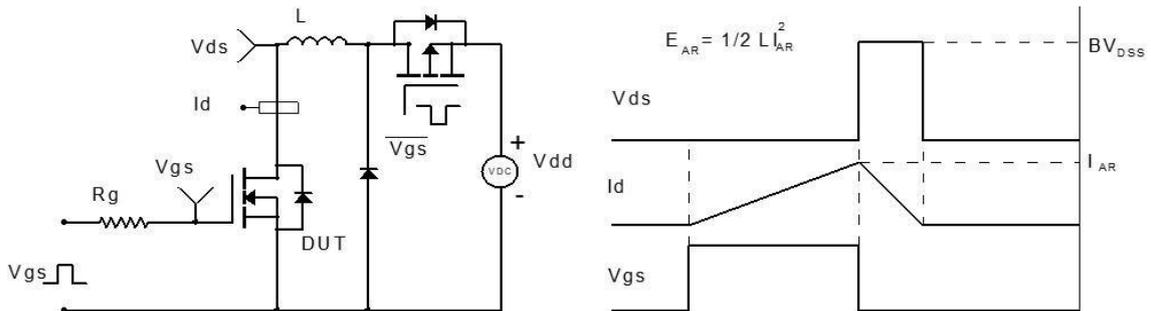
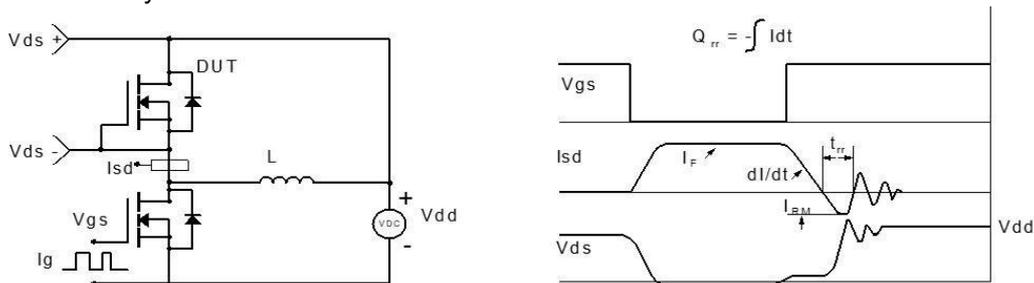


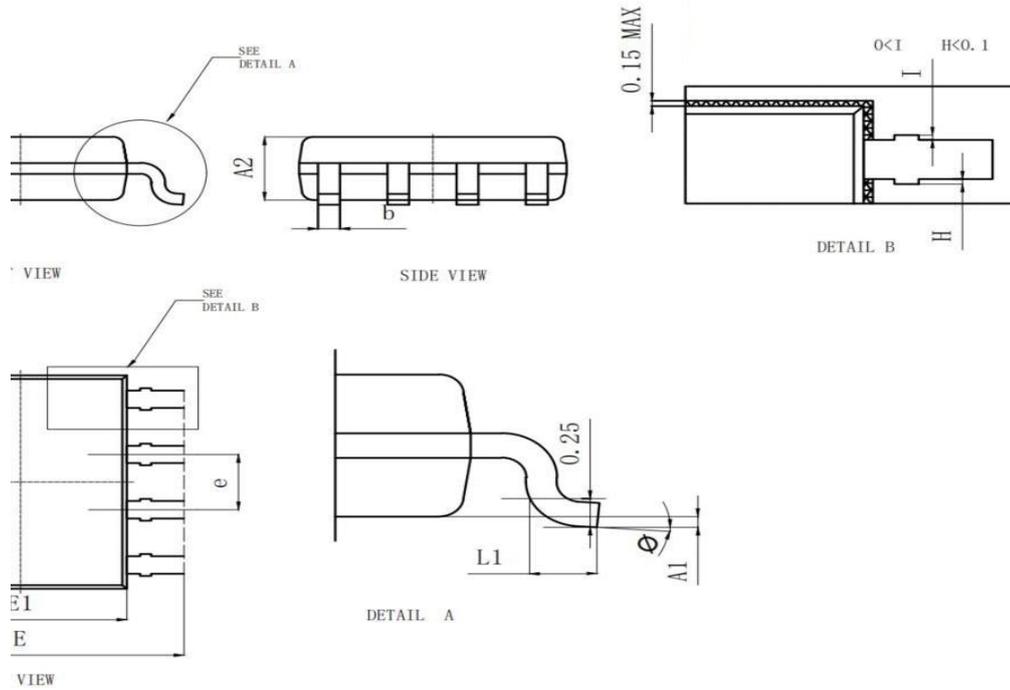
Fig 4. Diode Recovery Test Circuit & Waveform





**PACKAGE INFORMATION**

Dimension in SOP-8 (Unit: mm)



Symbol	MILLIMETER	
	Min.	Max.
A	0.030	0.150
A2	1.425	1.475
b	0.300	0.500
c	0.150	0.250
D	4.800	5.200
E	5.800	6.200
E1	3.800	4.200
e	1.270BSC	
L1	0.400	0.800
H, 1	0	0.100
∅	0°	8°



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